

## SEARCHED

Class	Sub.	Date	Exmr.
455	434 435.2 435.3 524 525 552.1 432.1	04/21/01 ↓ ↓	IQ ↓ ↓
Updated	search	5/16/05	R.P.G.
Updated	search	9/5/05	R.P.G.
455	435.1	9/5/05	R.P.G.

## INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.
455	525 435.3 434 552.1	9/5/05 9/5/05 9/5/05 9/5/05	R.P.G. R.P.G. R.P.G. R.P.G.

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
Interview with Rafael Perez, case presentation	04/20/04	IQ
Interview with Rafael Perez, Search keywords and relevant art	04/21/04	IQ
Interview with Nguyen T. Vo, Search keywords, relevant art	04/22/04	IQ
EAST Image and keyword search in USPAT, USPPAUS, DEKWINT, EPO, JPO, and IBM-TDS	5/16/05	R.P.G.
WIPO Database <a href="http://patgate.wipo.int">http://patgate.wipo.int</a>	5/16/05	R.P.G.
EPO Database <a href="http://ep.eispatent.com/">http://ep.eispatent.com/</a>	5/16/05	R.P.G.
IEEE Xplore <a href="http://ieeexplore.ieee.org/Xplore/Patent">http://ieeexplore.ieee.org/Xplore/Patent</a>	5/16/05	R.P.G.
Inventor names and Assignee search in PALM Expo and EAST	5/16/05	R.P.G.

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